



# Dual N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)			
30	0.040 at V <sub>GS</sub> = 10 V	5.8	2.8 nC			
	0.050 at V <sub>GS</sub> = 4.5 V	5.5	2.0 110			

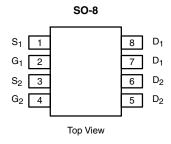
#### **FEATURES**

- TrenchFET® Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

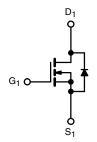


#### **APPLICATIONS**

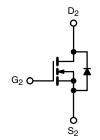
- Low Current DC/DC Conversion
- Notebook System Power



Ordering Information: Si4936CDY-T1-E3 (Lead (Pb)-free)







N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS (1 <sub>A</sub> = 25 °C	, uniess oth	erwise noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		5.8	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	4.6	
Continuous Brain Current (1) = 130 C)	T <sub>A</sub> = 25 °C		5 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		4 <sup>a, b</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	20	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I.	1.9	
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	1.4 <sup>a, b</sup>	
	T <sub>C</sub> = 25 °C		2.3	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.5	w
	T <sub>A</sub> = 25 °C		1.7 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C	1	1.1 <sup>a, b</sup>	
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	$R_{thJA}$	58	75	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	42	55	O/ <b>VV</b>		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on  $T_C = 25$  °C.

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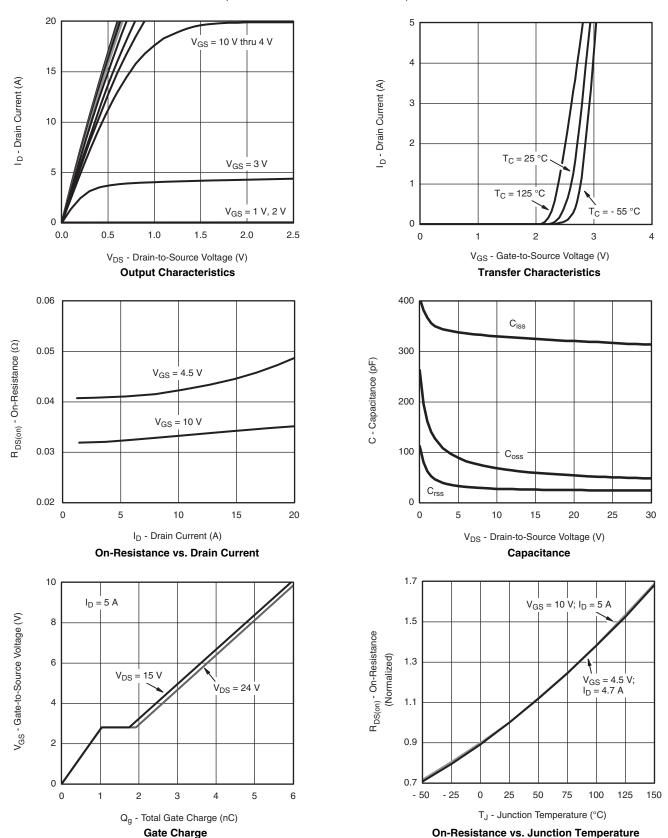
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				7.			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		32			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1.2		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	15			Α	
	Б	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		0.033	0.040	_	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 4.7 \text{ A}$		0.041	0.050	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 5 \text{ A}$		15		S	
Dynamic <sup>b</sup>	<u>.                                      </u>		·				
Input Capacitance	C <sub>iss</sub>			325			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		60		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			30			
Total Oats Observe	Q <sub>g</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		6	9	nC	
Total Gate Charge				2.8	4.2		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		1.1			
Gate-Drain Charge	$Q_{gd}$			0.8			
Gate Resistance	$R_g$	f = 1 MHz	0.6	2.8	5.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			12	18		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.8 $\Omega$		13	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 4$ A, $V_{GEN}=4.5$ V, $R_g=1$ $\Omega$		16	25		
Fall Time	t <sub>f</sub>			11	17		
Turn-On Delay Time	t <sub>d(on)</sub>			4	8	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.8 $\Omega$		9	18		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 4$ A, $V_{GEN}=10$ V, $R_g=1$ $\Omega$		11	20		
Fall Time	t <sub>f</sub>			8	15		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			1.9	^	
Pulse Diode Forward Current	I <sub>SM</sub>				20	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 4 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			11	20	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 4 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		4	8	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$i_F = 4 \text{ A}$ , $ui/ui = 100 \text{ A}/\mu s$ , $i_J = 25 \text{ C}$		6			
Reverse Recovery Rise Time	t <sub>b</sub>	7		5		ns	

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



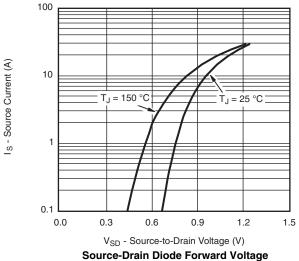
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T<sub>J</sub> = 125 °C

 $T_J = 25~^{\circ}C$ 

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



0 V<sub>GS</sub> - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage

0.10

0.08

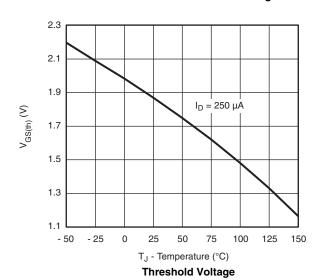
0.06

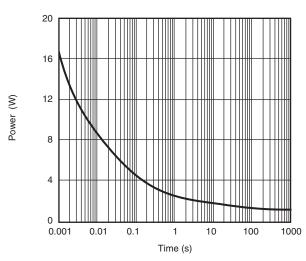
0.04

0.02

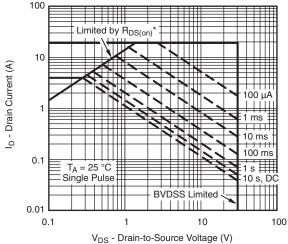
0.00

R<sub>DS(on)</sub> - On-Resistance (Ω)





Single Pulse Power

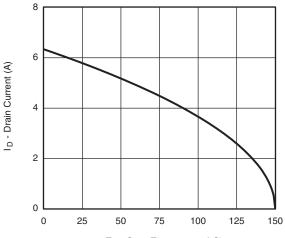


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

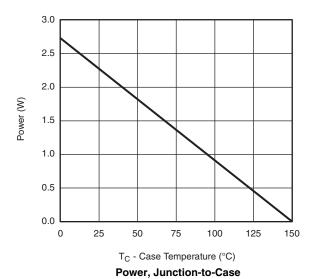


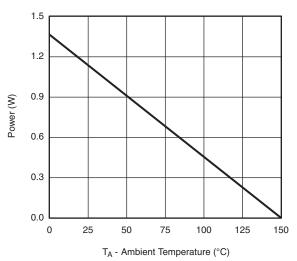
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***



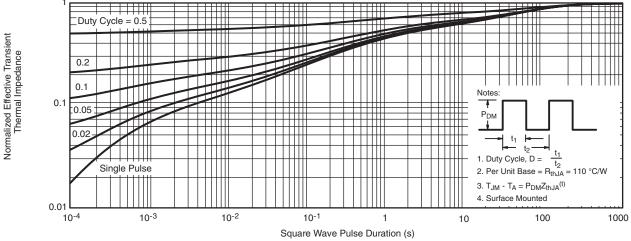


Power, Junction-to-Ambient

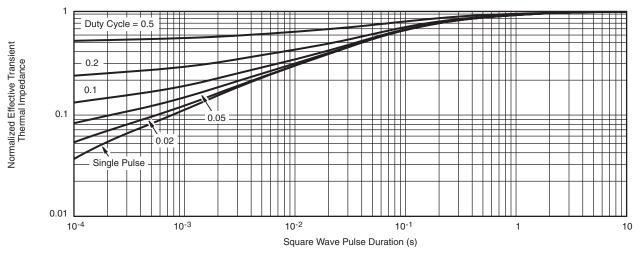
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	INCHES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

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### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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